University of Massachusetts Lowell James B. Francis College of Engineering Department of Mechanical Engineering 22.302 - Laboratory I

Section and Group number:	
Experiment Number and Title:	Experiment #
	LVDT and Accelerometer Calibration
	with Applications
Date of Experiment:	March 9, 2004
Report Prepared by:	
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- Team Member #2	
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Instructors Comments:

Date of submission: .....

Comments:

#### Introduction:

A transducer is a device that converts engineering quantities (pressure, temperature, displacement, velocity, acceleration, etc...) into electrical energy. Two types of transducers were calibrated in this experiment, one which measured displacement (LVDT) and one which measured acceleration (accelerometer). Before any transducers can be used for measurements, calibration must be performed. The following paragraphs outline the procedure and results of the calibration of an LVDT and accelerometer.

## **Objectives:**

The objective of this laboratory experiment was to determine the sensitivities of both the LVDT and the accelerometer. In addition, familiarity was gained with common calibration equipment and procedure.

## **Discussion:**

The calibration of the accelerometer was performed using an electrodynamic calibration shaker. The calibration shaker armature was able to compensate for the weight of the accelerometer and provide a constant 1 g<sub>rms</sub> sinusoidal excitation signal at 100 Hz. With the input acceleration known, both an oscilloscope and multimeter then measured the electrical signal output from the accelerometer. From the accelerometer output data, the sensitivity of the accelerometer was determined to be 0.1785 V/g. For detailed procedure and results of this calibration refer to Appendix B.

The calibration of the LVDT was performed using a mounted micrometer fixture. Once properly secured and wired, the LVDT was then displaced in known increments along its usable range such that the corresponding output voltage for each increment could be recorded. The voltage data was then imported into Microsoft Excel where linear regression was used to determine the sensitivity of the LVDT. Figure 1 shows the calibration data for displacement both into and out of the barrel of the LVDT along with the sensitivity of the LVDT, which was calculated to be 1.3731 V/in. For additional plots and procedures of the LVDT calibration refer to Appendix C.



Figure 1. LVDT Calibration incorporating both positive and negative portions of the calibration. Sensitivity is taken as the slope of this plot.

## **Conclusions:**

The lab was successful in showing how to correctly calibrate an LVDT and accelerometer. In addition, valuable experience was gained in setting up, executing, and processing data from a common transducer calibration.

#### **Recommendations:**

To improve on the quality of the data taken during the calibration of the LVDT it is advised that a redesign of the micrometer fixture be investigated. The current micrometer fixture made it very difficult to secure the LVDT such that no movement occurred during the calibration.

#### **References:**

1. Avitabile, Peter. LVDT and Accelerometer Calibrations with Applications. Lab Handout. 01/11/2002.

## Appendix A:

### Post-Lab Questions

1. Define the term sensitivity as it relates to a transducer.

Answer here...

2. Define what the null position of an LVDT is.

Answer here...

3. Determine the sensitivity of the LVDT. Generate a plot of the output voltage vs. input displacement of the core.

Answer here...

4. If the LVDT has a linear input range of +/- 3 inches with a corresponding output range of +/- 10 Vdc, what nominal sensitivity should this instrument have?

Answer here...

5. Is the calibrated sensitivity different from the expected value? Why may these values differ?

Answer here...

6. Determine the sensitivity of the accelerometer.

Answer here...

7. What means can be used to determine if the accelerometer was calibrated at 100Hz?

Answer here...

8. How accurate are the experimental sensitivities of the LVDT and accelerometer? Discuss the sources for error.

Answer here...

9. Discuss an alternate means of calibrating an accelerometer.

Answer here...

## Appendix B

### Accelerometer Calibration Procedure and Results

An electrodynamic shaker, seen in Figure B1, was used in conjunction with a multimeter and oscilloscope to calibrate the accelerometer. By recording the voltage output of the accelerometer in response to the shaker's constant input acceleration (1  $g_{rms}$ ), the sensitivity was easily determined. (The data and sensitivity calculation can be seen in Tables B1 and B2, respectively.)

Calibration Procedure (Portions adapted from [1]):

- 1. Connect the accelerometer to the calibration equipment as shown in Figure B1. The accelerometer should be connected to the XDCR connector on the rear of the power supply using a microdot cable.
- 2. Determine if the power supply of the shaker is functioning properly. Turn the left knob to the battery test position. Verify that the shaker power is sufficient by observing if the needle moves into the graduated area.
- 3. Set channel 2 on the oscilloscope to DC coupling. Adjust the vertical scale to 0.2 volts/div.
- 4. Test the response of the system by gently tapping the bottom of the accelerometer. Note the polarity of the signal on the oscilloscope. Tap the top of the accelerometer and note the resulting polarity of the signal.
- 5. Place a small amount of wax on the center of the accelerometer disk. Carefully attach the base of the accelerometer to the disk with a slight twisting motion.
- 6. Turn the power supply of the accelerometer and the accelerometer on.
- 7. Measure the  $V_{pp}$ ,  $V_{rms}$ , and period of oscillation of the transducer output with the oscilloscope and multimeter.



Figure B 1. Accelerometer calibration using the electromechanical shaker along with multimeter and oscilloscope.

Table B 1. Oscilloscope and Multimeter output values from the calibration of the accelerometer.

Multimeter	Oscilloscope		
			Frequency
Vout (rms)	Vpp	T (sec.)	(Hz)
0.1785	0.505	0.01	100

Sensitivity	=	.1785 V/g			
g =	32.1742	ft/s <sup>2</sup>	=	386.0904	in/s <sup>2</sup>
Sensitivity	=	0.000462327	V	/(in/sec <sup>2</sup> )	

## Appendix C:

## LVDT Calibration Procedure and Results

The LVDT used in the experiment had the following specifications:

Operating Temp.	0 – 160 deg F
Null Voltage	0 V <sub>DC</sub>
Linearity	0.25% full scale
Freq. Response (-3 dB)	200 Hz

The calibration of the LVDT required a +/- 15 V DC power supply and a mounted micrometer setup, which can be seen in Figure C1.



Negative Direction (Out of LVDT)



This data was recorded for two separate situations, where the first situation was the LVDT connecting rod moving into the LVDT (positive) and the second situation was the connecting rod moving out of the LVDT (negative). By combining the data from the positive and negative calibration procedures, the sensitivity over the entire linear range (+/- 3 in.) was found. The entire linear range sensitivity differed from the positive and negative range sensitivities by only 0.3% and 0.4% respectively. Since these differences were minimal, the sensitivity over the entire range was used for the final calibration. The data and plot for the positive range can be seen in Table C1 and Figure C2 respectively, and the data and plot for the negative range can be seen in Table C2 and Figure C3 respectively. The final sensitivity plot, denoting a sensitivity of 1.3731 V/in., can be seen in Figure 1.

Calibration Procedure (Adapted from [1]):

- 1. Adjust the micrometer screw of the calibration fixture to the middle zero position. The micrometer has a marked travel of 3 inches with a resolution of 0.001 inches.
- 2. Attach the core connecting rod to the micrometer and to the core.
- 3. Install the LVDT in the calibration fixture. Use the adapting sleeves to shim the LVDT as necessary.
- 4. Verify that the LVDT power supply is off. Connect the LVDT to the power supply using the "D" to bendix cable. Connect the output from the transducer to the input of the multimeter and oscilloscope. Turn on the power supply
- 5. Adjust the LVDT in the fixture to the null position. An output of zero volts should be observed on the multimeter in the DC mode. Tighten the LVDT to the fixture. Verify that the micrometer is still at the middle zero setting.
- 6. Adjust the micrometer an amount that displaces the core three tenths of an inch (four complete revolutions of the micrometer screw). Record the distance and output voltage. Repeat this process with measurement intervals of three tenths of an inch for a total travel of three inches.

Δx (in.)	V <sub>DC</sub>
0	0
0.3	0.405
0.6	0.8235
0.9	1.233
1.2	1.647
1.5	2.061
1.8	2.4615
2.1	2.8845
2.4	3.294
2.7	3.7035
3	4.1175
2.7	3.7035
2.4	3.3255
2.1	2.9205
1.8	2.5065
1.5	2.097
1.2	1.6875
0.9	1.2645
0.6	0.846
0.3	0.45
0	0.036

Table C 1. LVDT calibration data from displacing connecting rod into LVDT core (positive).



Figure C 2. Positive LVDT calibration plot with linear fit.

Δx (in.)	V <sub>DC</sub>
0	0.036
-0.3	-0.378
-0.6	-0.792
-0.9	-1.242
-1.2	-1.6155
-1.5	-2.034
-1.8	-2.4525
-2.1	-2.871
-2.4	-3.2895
-2.7	-3.7035
-3	-4.1175
-2.7	-3.7125
-2.4	-3.294
-2.1	-2.88
-1.8	-2.457
-1.5	-2.0385
-1.2	-1.62
-0.9	-1.2195
-0.6	-0.7965
-0.3	-0.378
0	0.0135

Table C 2. LVDT calibration data from displacing connecting rod out of LVDT core (negative).



Figure C 3. Negative LVDT calibration data with linear fit.

# Appendix D:

## Equipment Used

Model	Serial Number	Description
UML LVDT ±15V	CAL-42M	Linear Variable Displacement Transducer
Nat'l Instruments	002540	50 Pin Ribbon
Tektronix 2225	16666251145134	50 Mhz Oscilloscope
1557-A	2882	Vibration Calibrator
Fluke 8010A Digital Multimeter	4380137	Digital Multimeter

## Appendix E:

## Lab Notebook

Correlation of Shock Absor Displacement and Accel Response	oer eration		03/12/04 - 5
Response <u>Equipment</u> ± 15 V DC PWR Supply Power Supply Digital Multimeten 50 Mtz Oscilloscope	5/N 1591-D 237 4380137 2825-D010452	Model 433AØ3 8010A 2225	Manufacturer Hammond PCB Fluke TekTronix
D-Bit A/DC Board LVDT Accelerometer Electromechanical Shiker Spring/Strut/Axte Assembly Steel Support Structure Shaker Table	002540 435N 19090 1071 5793-UML AIG492	1000HCD 330A 394B06 	Schoevitz Ehgineen PCB PCB BMW UMJSS-Lowell PMC Beta
Setting of Equipment Digital Data Acquisition S - Ch 0 -> - Ch 1 -> - Sample Rate 10	System(DAS) - LVDT Data Accelerometer I 600 Sumple Kecono	LabView is b Duta d =7 3200	seing used total samples taken
Oscilloscope - Initial S Ve Channel 2	ttings utical scale = set at DC	0.2 V/divisio	,
Multimeter - DC Mo	de	<u>7.A</u> .	03/10/04-5 Churtytes Q. Atto June MAL

		02 h / h - h
	Calibration of	LVDT
	Note: Moltimete	is zeroed - Reading is 0.00 V initially.
	Displacement of	Cone into LVDT ->
		LUDT
	$\Delta X$ (in.)	V (Dc)
	Ö	O CMD 03/12/04
	0.1	0.135
	6,0	0,2745
a second s	0.3	0,411
	0,4	0.549
	0,5	0.687
	0.6	0.8205
$\subseteq$	0,7	0.9615
	0.8	1.098
	0.9	1.2345
	1.0	1.3725
	0.9	1.2345
	0,8	1.1085
	0.7	0.9735
	0.6	0.8355
	0,5	0-699
	0.4	0.5625
	0.3	0.4215
	0.2	0,282
	0.1	0.15 Note:
	6	0.012 -> Slight offset upon return to
		Stanting position.
	-	]
~	Estimate &	7. Pensitivity of LVDT-Positive
	SX- 18	725V- 13725× 03/12/14-6
	22 1	in thendrit
		B. mun

	Carlor around -	water Dr. value of 0.02 V
	Note: Multimeter	has 2000 reading No adjustments needed
		CMD 0310/04
	Displacement of	Core out of LVDT
	DX(n)	V (UC)
	0	0.012
	-0.1	- 0.264
	-0,2	-0414
	-0.5	-0.5285
*****	-15	-0.5505
	-0.6 -0.6	0.675
	-07	-0.957
		-1.0965
	-0.0	-1,2345
	= 0.1	-1.3725
	- 0.9	-1,2375
	- 0.8	-1.098
	-0.7	-0.94
	- 1 6	-1 819
	-0.5	-0.6795
	-0.4	-0.54
	-1.3	-0.4065
	-0.2	- 0.2655
	-0.1	-0.126
	0	0.0045
	Estimate of	CENSITIVIAL OF LVDT -NOUNTING
	AV 1200	5 V
	AX = 1.300	2 = 1.3605 in natalou
	111	1 alutation of the

I

03/12/04-8 Calibration of Accelerometer Note: Electromechumical Shaker is badly dented - possible damage Bonding solution is used to secure acceleremeter Multimeter Reading: = 0.1785 V(rms) Oscilloscopi - Vp=0.505 Scale on OScope adjusted to 0.05 Ju 0.002 ms Estimate of period - 37 3.35-3.4 divisions. T= 0.0067 = f \$ 150 Hz Execution of Experiment Labrew Data Stored on CMD's Floppy in ME Lab I fold Filenames: "Test I" and "Test II" Observation: Lot of Squarking of the joints on support Struce Room Sharking Violenbly Spring is very worn and risted Usul 03/12/04. Clu Mm